

# Intelligent Automation of Diagnosis Process in Semiconductor Product Testing

NUS ISEM IE3100M Systems Design Project





#### 1. Background

- **Infineon Technologies:** 
  - A world leader in semiconductor solutions
  - Asia Pacific headquarters located in Singapore
- Product Test Engineering (PTE) Department:
  - Final gate of defence in the entire semiconductor manufacturing process
  - Primarily responsible for the final testing of products
- Semiconductor Manufacturing Process:













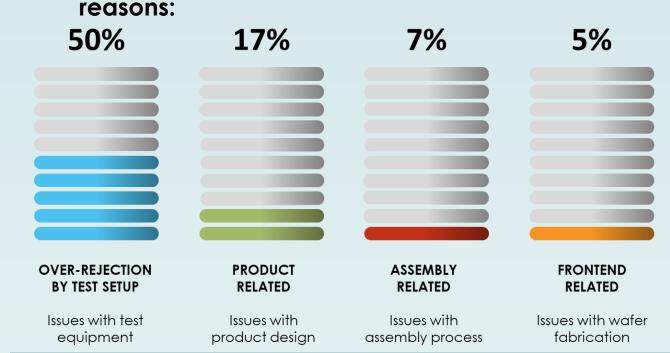




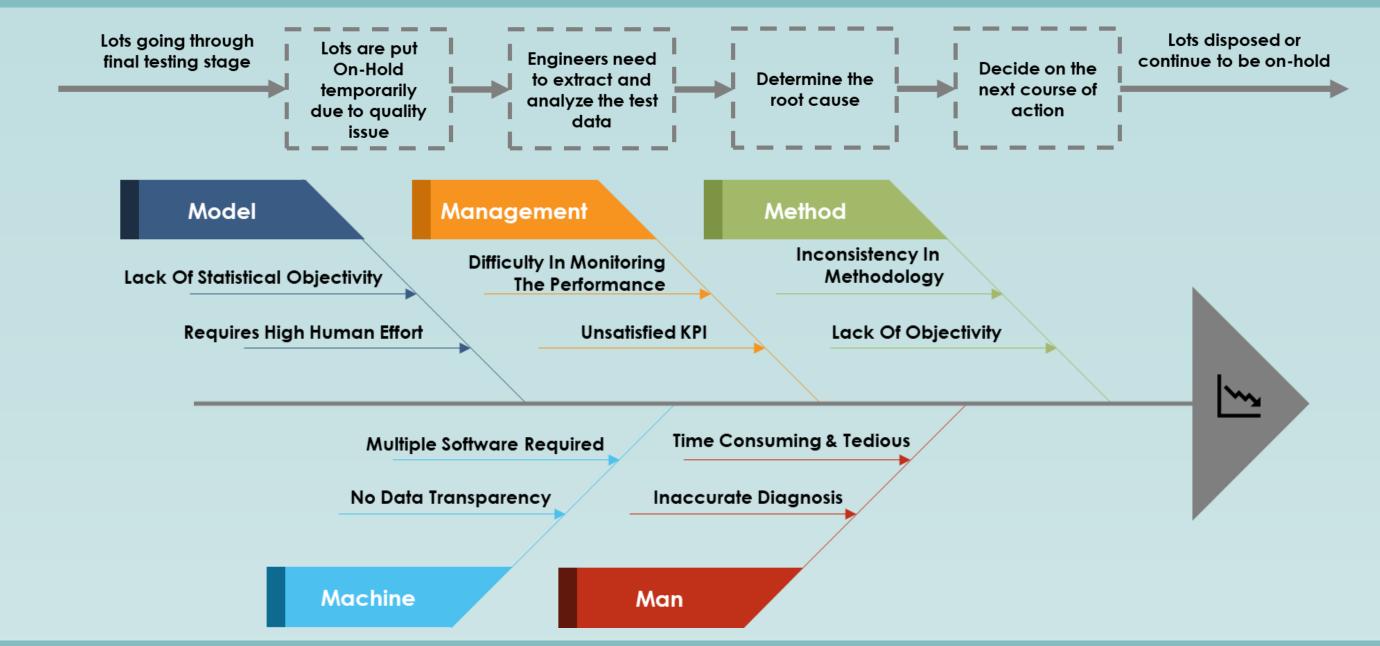
- Lots are put on-hold temporarily if they fail any test
- Product Engineers need to analyze the lots to decide on the root cause of test failure and subsequent action

#### 3. Objectives

- To develop an intelligent software that automates the LOH diagnosis process
- To improve efficiency and accuracy of current process
- To cover 80% of LOH, due to these four main



#### 2. Problem Drivers

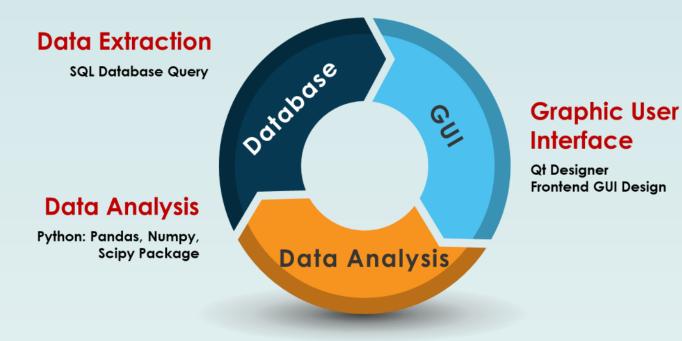


#### 4. Methodology

#### **Statistical Analysis**

#### **Chi-Square Test Multiple Criteria** P-value is used to detect the site issue: Bar-plot of **Decision Making** different sites will be provided for reference. Commonality test utilizes MCDM. Ranks are assigned to different issues based on certain criteria and historical plot performance to diagnose other test equipment issues. **Decision Tree** Decision Tree to rank the **Decision** possible diagnosis and Tree give disposition suggestions to the users

#### **Software Development**

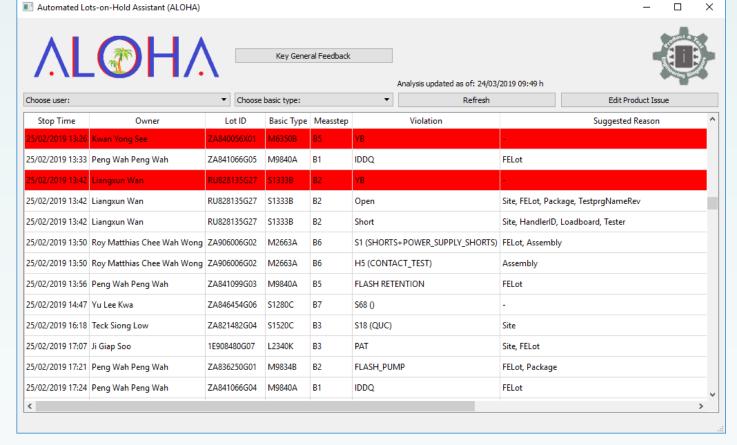


#### 5. Deliverables

#### **Automated Lots-On-Hold Assistant (ALOHA)**

Frontend Graphic User Interface (GUI)

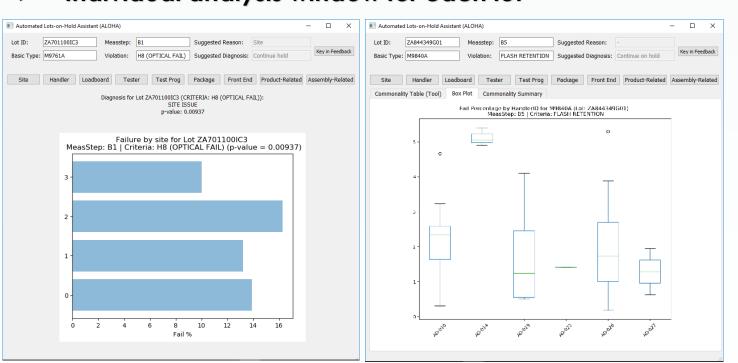
#### Dashboard



#### Dashboard functionality:

- √ Filter by User ID, Basic Type
- Refresh tab
- Edit Product Issue tab for user input from product catalogue
- Columns to suggest LOH reason and disposition

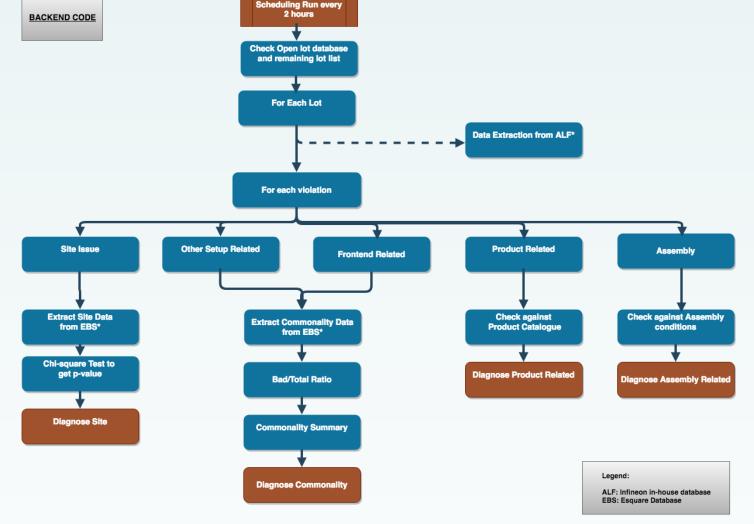
### Individual analysis window for each lot



#### Individual window functionality:

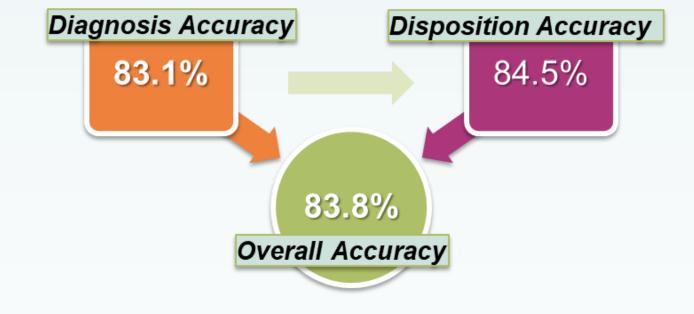
- Different tab for different diagnosis
- Commonality table, bar plot and box plot for visualization of analysis
- Output message for Assembly and Product Related issue

### **Backend Code**



## 6. User Acceptance Testing (UAT)

- Software was piloted on selected engineers from 22<sup>nd</sup> Jan 2019 to 1<sup>st</sup> March 2019
- During the UAT period, the backend code was scheduled to run 24/7 and pilot engineers were tasked to use the GUI for their daily LOH diagnosis
- UAT Target: Accuracy of software diagnosis  $\geq 80\%$ .
- **UAT Results:** 
  - √ 1143 lots analysed by software during UAT



## 7. Achievement and Future Development

- Software will be rolled out to the entire Singapore test site on 1st April 2019
- Improvements to software were made based on users' feedback during UAT
- Preparation for Machine Direction: Learning

#### **MACHINE LEARNING MORE ACCURATE CLASSIFICATION DIAGNOSIS ENGINE** X **ALOHA ROLL OUT** WITH ALOHA TO PRODUCT TEST **OUTPUT ENGINEERS**

#### 8. Conclusion

Skill-sets acquired in the System Design Project:

